

MOS FIELD EFFECT TRANSISTOR

NP80N04EHE, NP80N04KHE

NP80N04CHE, NP80N04DHE, NP80N04MHE, NP80N04NHE

SWITCHING

N-CHANNEL POWER MOS FET

DESCRIPTION

These products are N-channel MOS Field Effect Transistors designed for high current switching applications.

ORDERING INFORMATION

| PART NUMBER | LEAD PLATING | PACKING | PACKAGE |
|---------------------------------------|---------------|-----------------|-----------------------------------|
| NP80N04EHE-E1-AY ^{Note1, 2} | Pure Sn (Tin) | Tape 800 p/reel | TO-263 (MP-25ZJ) typ. 1.4 g |
| NP80N04EHE-E2-AY ^{Note1, 2} | | | |
| NP80N04KHE-E1-AY ^{Note1} | | | TO-263 (MP-25ZK) typ. 1.5 g |
| NP80N04KHE-E2-AY ^{Note1} | | | |
| NP80N04CHE-S12-AZ ^{Note1, 2} | Sn-Ag-Cu | Tube 50 p/tube | TO-220 (MP-25) typ. 1.9 g |
| NP80N04DHE-S12-AY ^{Note1, 2} | Pure Sn (Tin) | | TO-262 (MP-25 Fin Cut) typ. 1.8 g |
| NP80N04MHE-S18-AY ^{Note1} | | | TO-220 (MP-25K) typ. 1.9 g |
| NP80N04NHE-S18-AY ^{Note1} | | | TO-262 (MP-25SK) typ. 1.8 g |

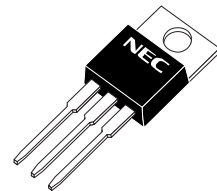
Notes 1. Pb-free (This product does not contain Pb in the external electrode.)

2. Not for new design

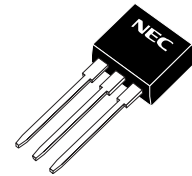
FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance
 $R_{DS(on)} = 8.0 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 40 \text{ A)}$
- Low input capacitance
 $C_{iss} = 2200 \text{ pF TYP.}$
- Built-in gate protection diode

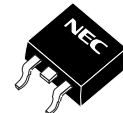
(TO-220)



(TO-262)



(TO-263)



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ABSOLUTE MAXIMUM RATINGS (T_A = 25°C)

| | | | |
|---|-----------------------|-------------|----|
| Drain to Source Voltage (V _{GS} = 0 V) | V _{DSS} | 40 | V |
| Gate to Source Voltage (V _{DS} = 0 V) | V _{GSS} | ±20 | V |
| Drain Current (DC) (T _C = 25°C) ^{Note1} | I _{D(DC)} | ±80 | A |
| Drain Current (Pulse) ^{Note2} | I _{D(pulse)} | ±280 | A |
| Total Power Dissipation (T _A = 25°C) | P _T | 1.8 | W |
| Total Power Dissipation (T _C = 25°C) | P _T | 120 | W |
| Channel Temperature | T _{ch} | 175 | °C |
| Storage Temperature | T _{stg} | -55 to +175 | °C |
| Single Avalanche Current ^{Note3} | I _{AS} | 52/31/13 | A |
| Single Avalanche Energy ^{Note3} | E _{AS} | 2.7/96/169 | mJ |

Notes 1. Calculated constant current according to MAX. allowable channel temperature.

2. PW ≤ 10 μs, Duty cycle ≤ 1%

3. Starting T_{ch} = 25°C, R_G = 25 Ω, V_{GS} = 20 → 0 V (See **Figure 4.**)

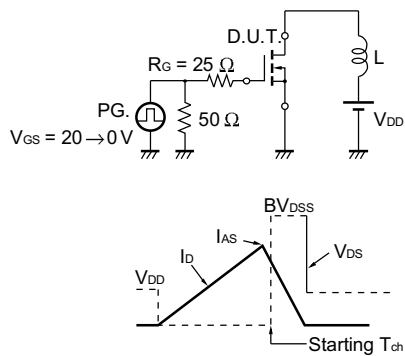
THERMAL RESISTANCE

| | | | |
|---------------------------------------|-----------------------|------|------|
| Channel to Case Thermal Resistance | R _{th(ch-C)} | 1.25 | °C/W |
| Channel to Ambient Thermal Resistance | R _{th(ch-A)} | 83.3 | °C/W |

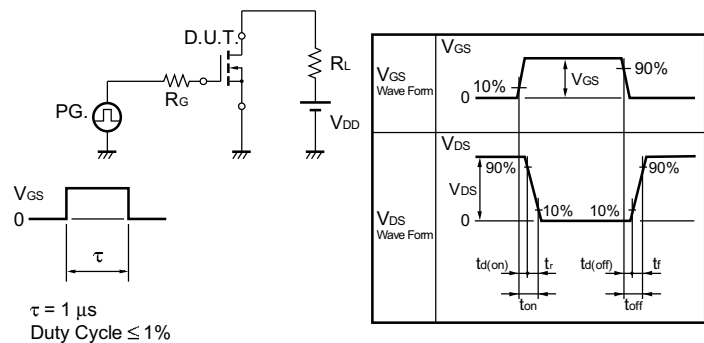
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

| Characteristics | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------------|---------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 40 V, V _{GS} = 0 V | | | 10 | μA |
| Gate to Source Leakage Current | I _{GSS} | V _{GS} = ±20 V, V _{DS} = 0 V | | | ±10 | μA |
| Gate to Source Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250 μA | 2.0 | 3.0 | 4.0 | V |
| Forward Transfer Admittance | y _{fs} | V _{DS} = 10 V, I _D = 40 A | 15 | 31 | | S |
| Drain to Source On-state Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 40 A | | 6.2 | 8.0 | mΩ |
| Input Capacitance | C _{iss} | V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz | | 2200 | 3300 | pF |
| Output Capacitance | C _{oss} | | | 490 | 730 | pF |
| Reverse Transfer Capacitance | C _{rss} | | | 230 | 410 | pF |
| Turn-on Delay Time | t _{d(on)} | V _{DD} = 20 V, I _D = 40 A, V _{GS} = 10 V, R _G = 1 Ω | | 24 | 52 | ns |
| Rise Time | t _r | | | 14 | 36 | ns |
| Turn-off Delay Time | t _{d(off)} | | | 44 | 88 | ns |
| Fall Time | t _f | | | 15 | 37 | ns |
| Total Gate Charge | Q _G | V _{DD} = 32 V, V _{GS} = 10 V, I _D = 80 A | | 40 | 60 | nC |
| Gate to Source Charge | Q _{GS} | | | 12 | | nC |
| Gate to Drain Charge | Q _{GD} | | | 16 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | I _F = 80 A, V _{GS} = 0 V | | 1.0 | | V |
| Reverse Recovery Time | t _{rr} | I _F = 80 A, V _{GS} = 0 V, di/dt = 100 A/μs | | 40 | | ns |
| Reverse Recovery Charge | Q _{rr} | | | 50 | | nC |

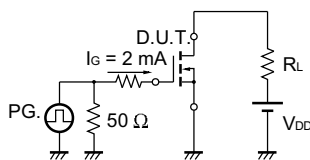
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE



TYPICAL CHARACTERISTICS (T_A = 25°C)

Figure1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

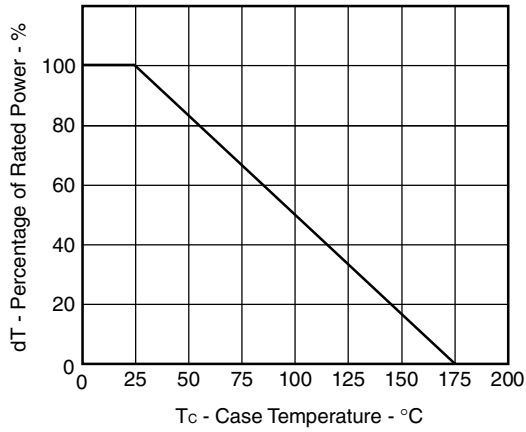


Figure2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

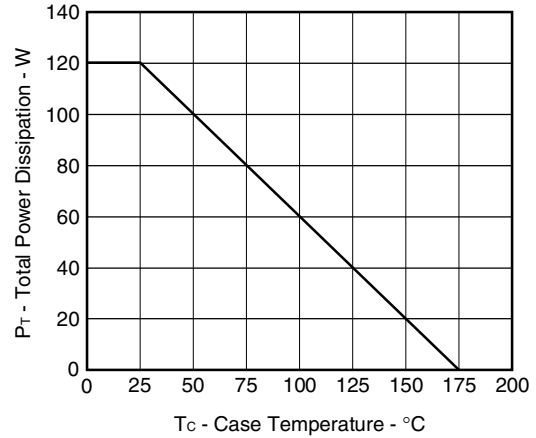


Figure3. FORWARD BIAS SAFE OPERATING AREA

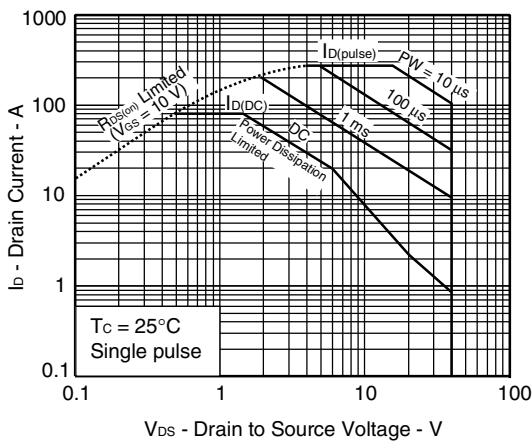


Figure4. SINGLE AVALANCHE ENERGY DERATING FACTOR

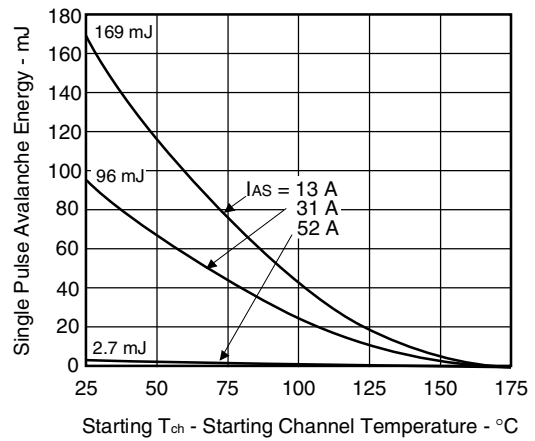


Figure5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

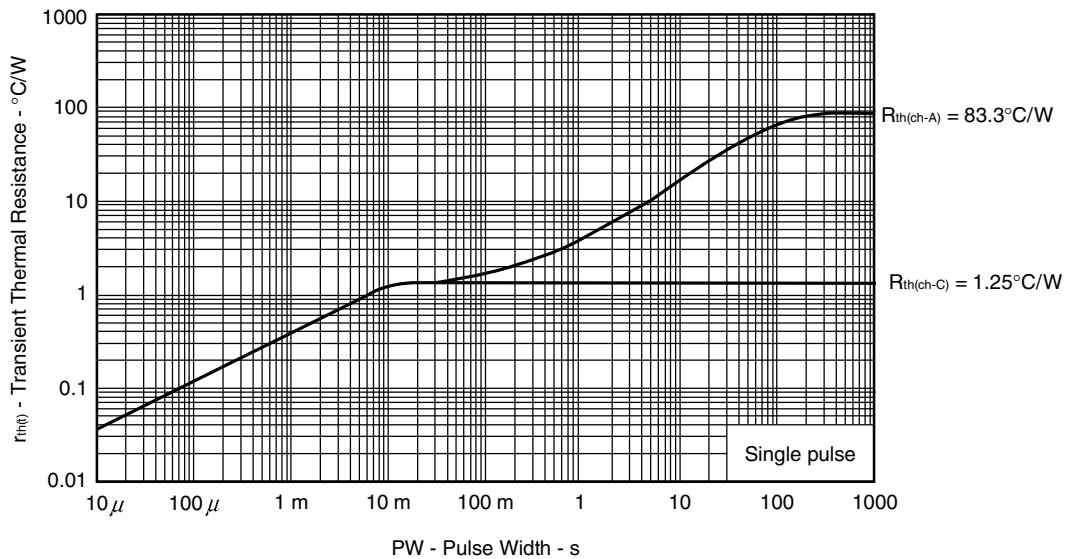


Figure6. FORWARD TRANSFER CHARACTERISTICS

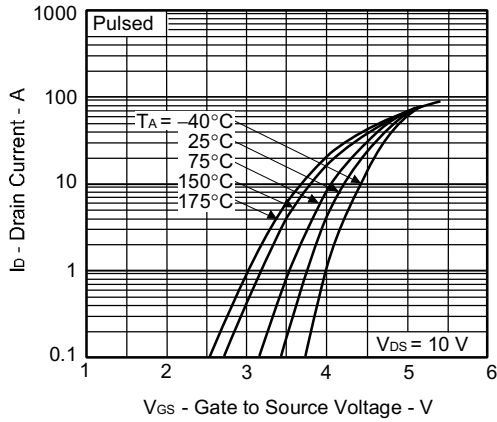


Figure7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

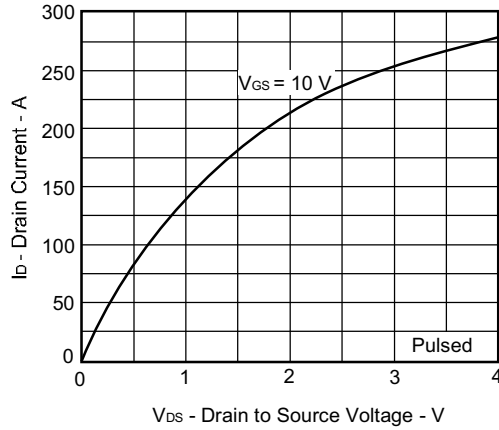


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

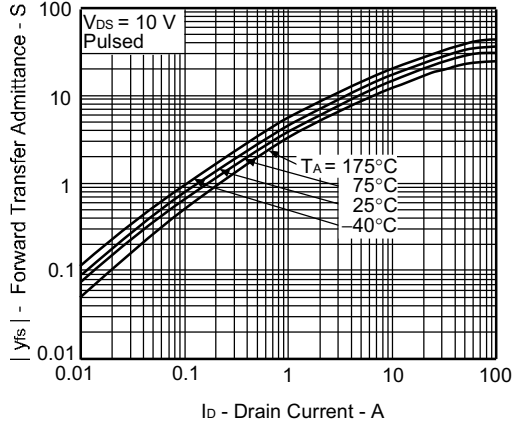


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

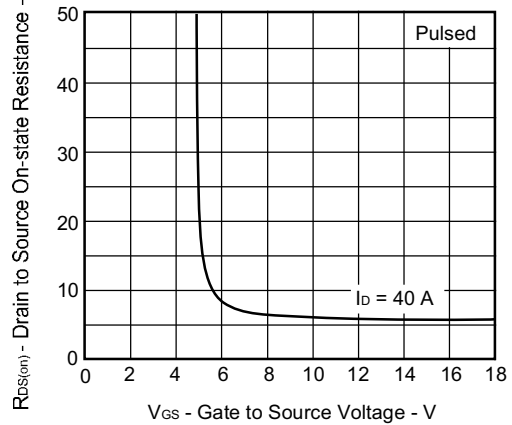


Figure10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

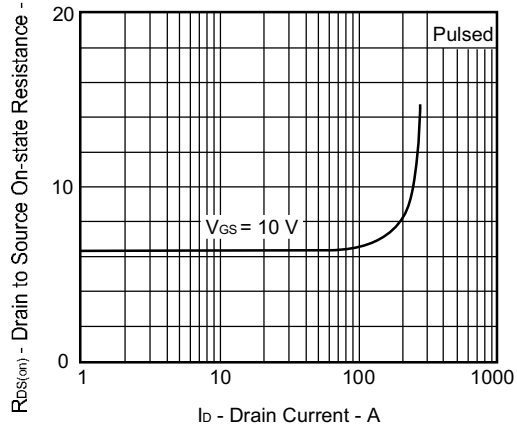


Figure11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

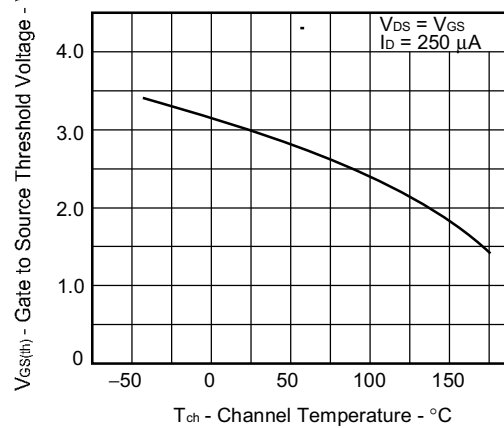


Figure12. DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

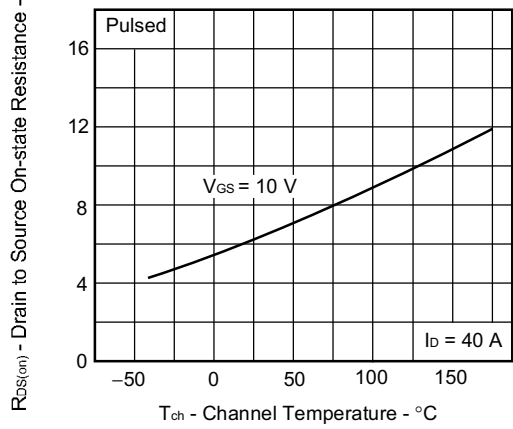


Figure13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

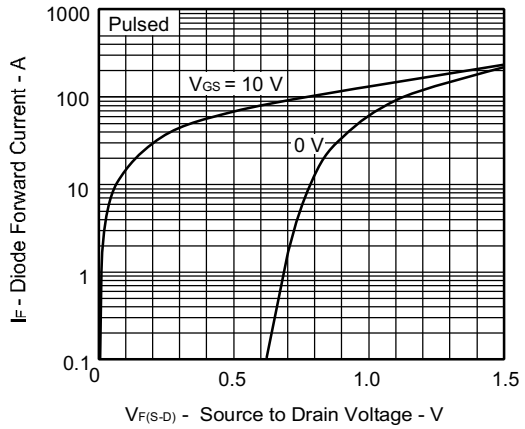


Figure14. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

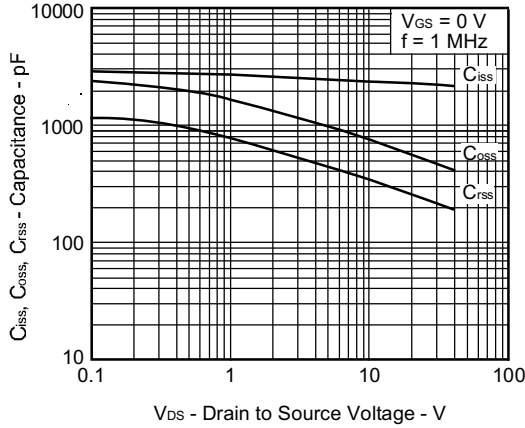


Figure15. SWITCHING CHARACTERISTICS

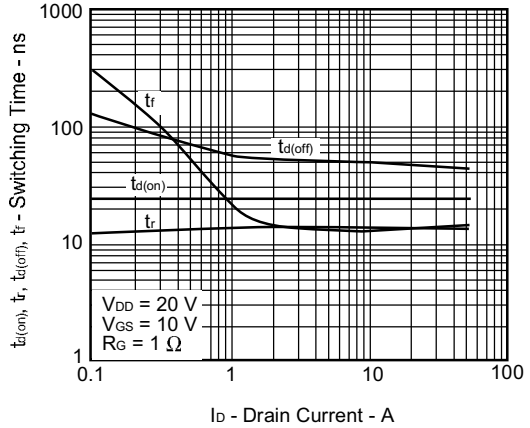


Figure16. REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

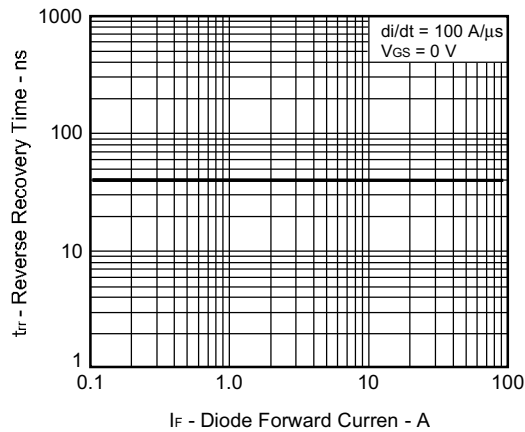
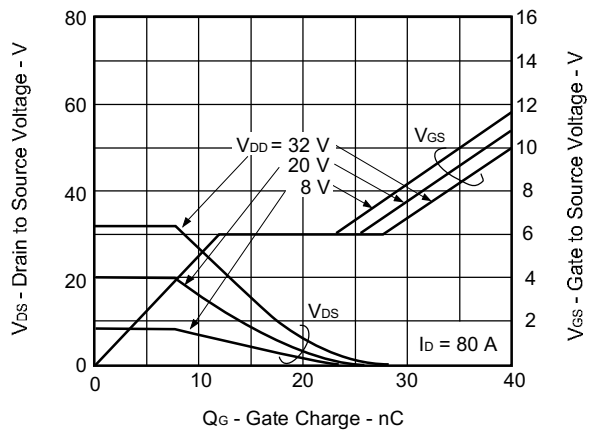
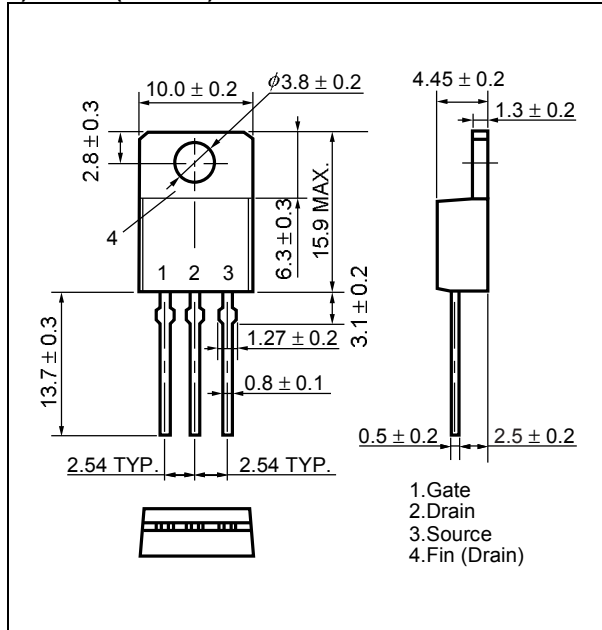


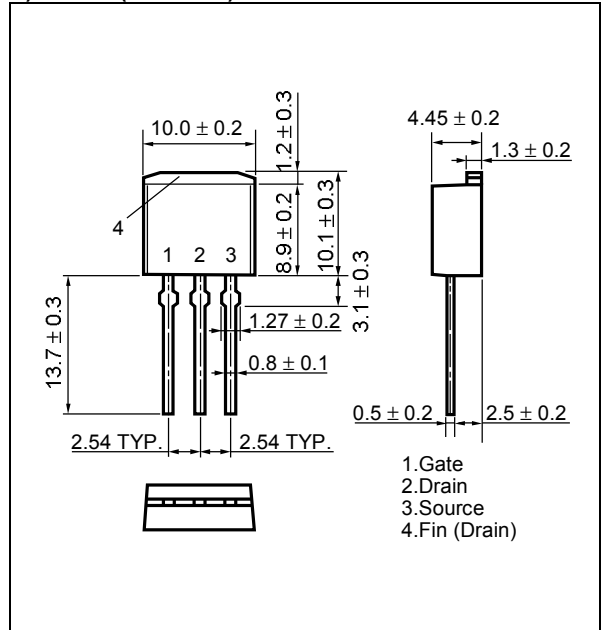
Figure17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS



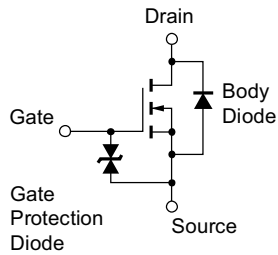
5) TO-220 (MP-25K)



6) TO-262 (MP-25SK)



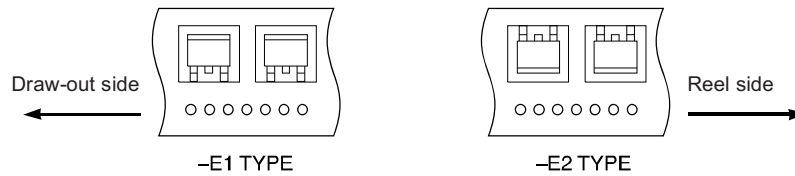
EQUIVALENT CIRCUIT



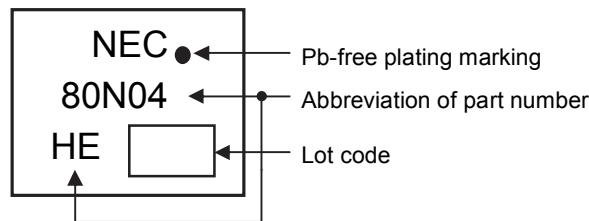
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

These products should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (<http://www.necel.com/pkg/en/mount/index.html>)

| Soldering Method | Soldering Conditions | Recommended Condition Symbol |
|--|--|------------------------------|
| Infrared reflow MP-25ZJ, MP-25ZK | Maximum temperature (Package's surface temperature): 260°C or below Time at maximum temperature: 10 seconds or less Time of temperature higher than 220°C: 60 seconds or less Preheating time at 160 to 180°C: 60 to 120 seconds Maximum number of reflow processes: 3 times Maximum chlorine content of rosin flux (percentage mass): 0.2% or less | IR60-00-3 |
| Wave soldering MP-25, MP-25K, MP-25SK, MP-25 Fin Cut | Maximum temperature (Solder temperature): 260°C or below Time: 10 seconds or less Maximum chlorine content of rosin flux: 0.2% (wt.) or less | THDWS |
| Partial heating MP-25ZJ, MP-25ZK, MP-25K, MP-25SK | Maximum temperature (Pin temperature): 350°C or below Time (per side of the device): 3 seconds or less Maximum chlorine content of rosin flux: 0.2% (wt.) or less | P350 |
| Partial heating MP-25, MP-25 Fin Cut | Maximum temperature (Pin temperature): 300°C or below Time (per side of the device): 3 seconds or less Maximum chlorine content of rosin flux: 0.2% (wt.) or less | P300 |

Caution Do not use different soldering methods together (except for partial heating).

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